

<p align="center"><b>LIST OF ART CITED BY APPLICANT</b> <b>(PTO-1449)</b></p>				ATTY. DOCKET NO. <b>P-0773</b>	APPLN. SERIAL NO. <b>10/576,880</b>		
				APPLICANT(S) <b>Yoon-Seob EOM et al.</b>			
				FILING DATE <b>April 21, 2006</b>	GROUP <b>3744</b>		
<b>U.S. PATENT DOCUMENTS</b>							
EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME	CLASS	SUBCLASS	FILING DATE	
	2,941,382	06/1960	Edward M. Wuesthoff				
<b>U.S. PATENT APPLICATION PUBLICATIONS</b>							
	*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS		
<b>U.S. PATENT APPLICATIONS</b>							
	*APPLN. NO.	*FILING DATE	*INVENTOR	CLASS	SUBCLASS		
<b>FOREIGN PATENT DOCUMENTS</b>							
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation Yes      No	
	JP 08-285321	11/01/1996	Japan (English Abstract and Japanese Full Text)			X	
	JP 06-002888	01/11/1994	Japan (English Abstract and Japanese Full Text)			X	
	DE 16 04 240	09/03/1970	Germany (German Full Text Only)				
	DE 16 04 243	12/10/1970	Germany (German Full Text Only)				
<b>OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)</b>							
EXAMINER			DATE CONSIDERED				

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.